

**Search Notes**



Application/Control No.

10/733,927

Examiner

Khawar Iqbal

Applicant(s)/Patent under Reexamination

JEONG ET AL.

Art Unit

2686

**SEARCHED**

Class	Subclass	Date	Examiner
455	450	12-19-5	Q
	403		
	432.1		
	435.1		
	436		
	437		
	440		
	446		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Fast search data	12-19-5	Q

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner